N-Channel Power MOSFET 60 V, 46 A, 16 m Ω

Features

- Low Gate Charge
- Fast Switching
- High Current Capability
- 100% Avalanche Tested
- These Devices are Pb-Free, Halogen Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

	$\begin{array}{c c c c c c c c c c c c c c c c c c c $				
Parar	neter		Symbol	Value	Unit
Drain-to-Source Voltage		V _{DSS}	60	V	
Gate-to-Source Voltag	e – Contir	nuous	V _{GS}	±20	V
Gate-to-Source Voltage - Non-Repetitive (t _p < 10 μs)			V _{GS}	±30	V
Continuous Drain		$T_{C} = 25^{\circ}C$	Ι _D	46	А
Current (R _{θJC})	-	$T_C = 100^{\circ}C$		33	
Power Dissipation $(R_{\theta JC})$	State	$T_C = 25^{\circ}C$	P _D	71	W
Pulsed Drain Current	t _p =	= 10 μs	I _{DM}	203	А
Operating Junction and	T _J , T _{stg}		°C		
Source Current (Body I	Source Current (Body Diode)				А
Single Pulse Drain-to-	(L =	E _{AS}	36	mJ	
Avalanche Energy	0.1 mH)	I _{AS}	27	А	
Lead Temperature for S (1/8" from case for 10 s		Purposes	ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	R_{\thetaJC}	2.1	°C/W
Junction-to-Ambient - Steady State (Note 1)	$R_{ hetaJA}$	49	

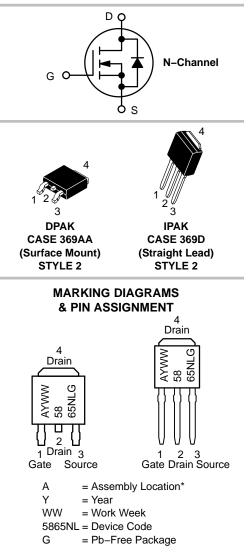
1. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.



ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX	
60 V	16 mΩ @ 10 V	46 A	
60 V	19 mΩ @ 4.5 V	A OF	



* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

ORDERING INFORMATION

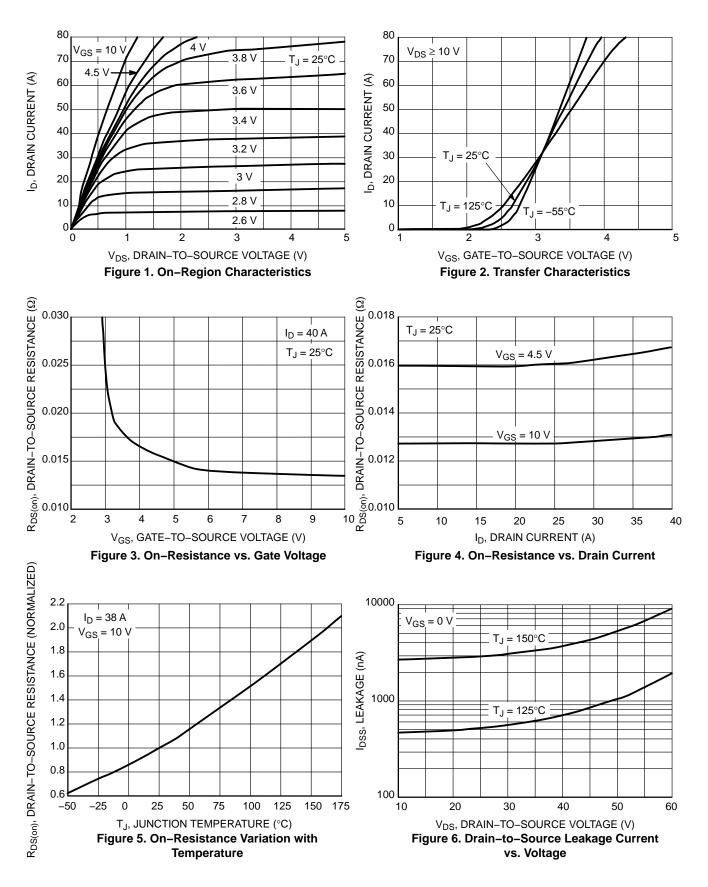
See detailed ordering and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise noted)

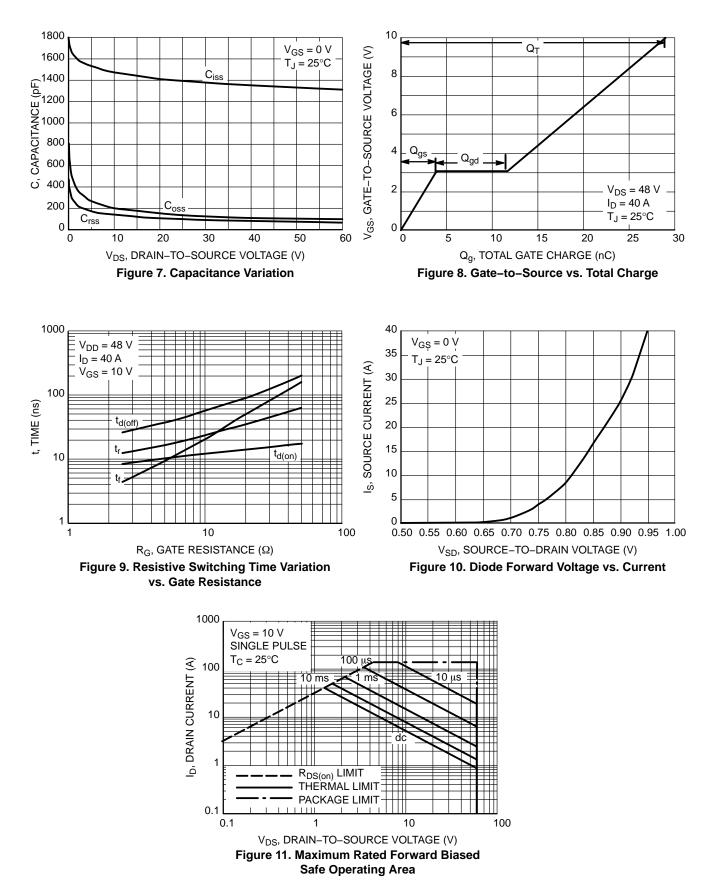
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \ \mu\text{A}$		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				55		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$			1.0	μΑ
		$V_{DS} = 60 V$	T _J = 150°C			100	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{G}$	_S = ±20 V			±100	nA
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 250 μA	1.0		2.0	V
Negative Threshold Temperature Co- efficient	V _{GS(TH)} /T _J				5.6		mV/°C
Drain-to-Source on Resistance	R _{DS(on)}	V _{GS} = 10 V, I	_D = 20 A		13	16	mΩ
Drain-to-Source on Resistance	R _{DS(on)}	V _{GS} = 4.5 V,	_D = 20 A		16	19	mΩ
Forward Transconductance	gFS	$V_{DS} = 15 \text{ V}, \text{ I}_{D} = 20 \text{ A}$			15		S
CHARGES, CAPACITANCES AND GA	TE RESISTANCE	S			•		
Input Capacitance	C _{iss}	V_{GS} = 0 V, f = 1.0 MHz, V_{DS} = 25 V			1400		pF
Output Capacitance	C _{oss}				137		
Reverse Transfer Capacitance	C _{rss}				95		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 48 V, I _D = 40 A			29		nC
Threshold Gate Charge	Q _{G(TH)}				1.1		
Gate-to-Source Charge	Q _{GS}				4		
Gate-to-Drain Charge	Q _{GD}				8		
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 48 \text{ V},$ $I_{D} = 40 \text{ A}$			15		nC
Gate Resistance	R _G				1.3		Ω
SWITCHING CHARACTERISTICS (Not	e 3)						
Turn-On Delay Time	t _{d(on)}				8.4		ns
Rise Time	t _r	V _{GS} = 10 V, V	= 48 V.		12.4		1
Turn–Off Delay Time	t _{d(off)}	$I_{\rm D} = 40 \rm A, R_{\rm C}$	$G = 2.5 \Omega$		26		
Fall Time	t _f				4.4		
DRAIN-SOURCE DIODE CHARACTER	RISTICS						
Forward Diode Voltage	V_{SD} $V_{GS} = 0 V$, $T_J = 25^{\circ}C$		T _J = 25°C		0.95	1.2	V
-		$I_{\rm S} = 40$ A	T _J = 125°C		0.85		
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dIs/dt = 100 A/μs, I _S = 40 A			20		ns
Charge Time	ta				13		
Discharge Time	tb				7		
Reverse Recovery Charge	Q _{RR}				13		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

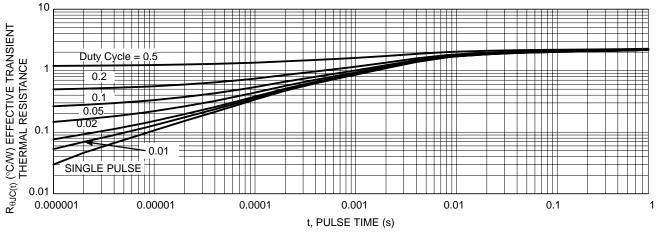


Figure 12. Thermal Response

ORDERING INFORMATION

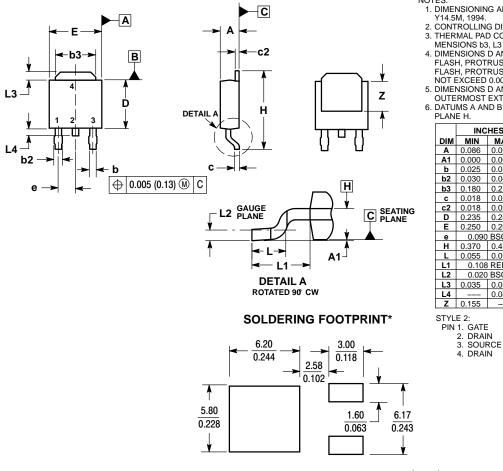
Order Number	Package	Shipping [†]
NTD5865NL-1G	IPAK (Straight Lead) (Pb-Free)	75 Units / Rail
NTD5865NLT4G	DPAK (Pb–Free)	2500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

DPAK (SINGLE GUAGE) CASE 369AA





NOTES:

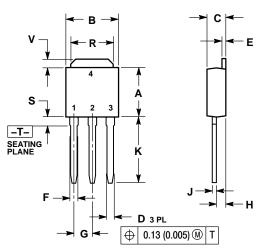
- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 2. CONTROLLING DIMENSION: INCHES.
 3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
 4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
 5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
- PLANE H.

	INC	HES	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.030	0.045	0.76	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
Е	0.250	0.265	6.35	6.73	
е	0.090	BSC	2.29 BSC		
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.108 REF		2.74 REF		
L2	0.020 BSC		0.51 BSC		
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Ζ	0.155		3.93		

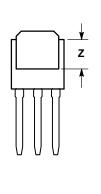
 $\left(\frac{\text{mm}}{\text{inches}}\right)$ SCALE 3:1

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS







D	ES:
	DIMENSIONING AND TOI FRANCI

NC

ING PER ANSI Y14.5M. 1982. CONTROLLING DIMENSION: INCH. 2.

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090 BSC		2.29 BSC	
н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
κ	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
V	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 2: PIN 1. GATE 2. DRAIN DRAIN 3. SOURCE 4 DRAIN

ON Semiconductor and the 💷 are registered trademarks of Semiconductor Components Industries, LLC (SCILLC) or its subsidiaries in the United States and/or other countries. SCILLC owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of SCILLC's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent–Marking.pdf. SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800–282–9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support:

Phone: 421 33 790 2910 Japan Customer Focus Center Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative